

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/719,395	BAI ET AL.	
Examiner	Art Unit	
Duy M. Dang	2624	

	SEAR	CHED			
Class	Subclass	Date	Examiner		
382	164, 171 173, 174 176	8/31/2007	DD		
	199 232				
	236 283				
	260 264				
345	467				
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INT	NTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
east (uspto, derwent, jpo, epo), see printouts	8/31/07	hur
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